265219US2PCT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Ryoji SETAKA, et al.

SERIAL NO:

10/522,536

GAU:

2833

FILED:

January 27, 2005

EXAMINER: HAMMOND, BRIGGITTE R.

EXAMINER. HAMMOND,

FOR:

ANISOTROPICALLY CONDUCTIVE CONNECTOR, CONDUCTIVE PASTE COMPOSITION, PROBE

MEMBER, AND WAFER INSPECTION APPARATUS AND WAFER INSPECTION METHOD

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

The applicant(s) wish to make of record the references listed on the attached European Search Report and form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.

☐ A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

□ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

Gregory J. Maier

Registration No. 25,599

Customer Number

22850

Tel. (703) 413-3000 Fax. (703) 413-2220 (OSMMN 05/03)

Form PTO 1449 U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.				
(Modified)		PATENT AND TRAD	E E	265219US2PCT		10/522,536			
LIST OF REFERENCES CITED BY APPLICANT & Rvoji SETAKA, et al.									
LIST OF	REFE	RENCES CITED BY API	PLICANT %	oji SETAKA, et al.					
MAY 1 6 2006				FILING DATE		GROUP			
MAY 1 6 2000 Ju				January 27, 2005		2833			
January 27, 2005 U.S. PATENT DOCUMENTS EXAMINER DOCUMENT SUB FILING DATE									
EXAMINER		DOCUMENT	DATE	NAME	CLASS	CLASS SUB FILING DATE			
INITIAL		NUMBER	DATE	NAME	CLASS	CLASS	CLASS IF APPROPRIATE		
	AA	5,586,892 A	12/24/1996	SATO, Minoru	ļ				
	AB	2001/0030019 A1	10/18/2001	SAITOH, Masao					
	AC								
	AD								
	ΑE								
	AF								
	AG								
	AH								
	Al							***	
	AJ			V = 1, J					
	AK								
	AL				 				
	AM								
	AN								
	7.11			DEIGN BATENT DOCUMENTS	1]			
FOREIGN PATENT DOCUMENTS									
		DOCUMENT NUMBER	DATE	COUNTRY		TRANS YES		ILATION NO	
	AO						-		
	AP								
	AQ								
	AR								
	AS								
	AT								
	AU								
	AV								
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
	AW								
	AX								
	AY	****	10. 10 · 10		/.				
	AZ				Additional References sheet(s) attached				
Examiner						Date Considered			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									